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Applicant(s)/Patent Under Reexamination	
SHIKAMI ET AL.	
Art Unit	
2624	
	Reexamination SHIKAMI ET AL.  Art Unit

<b>✓</b>	Rejected
11	Allowed

_	Cancelled
÷	Restricted

N	Non-Elected
•	Interference

A	Appeal
O	Objected

Claims	renumbered	l in the same order	as presented by	applicant		☐ CPA	☐ T.C	). ∐	R.1.47
CL	AIM				DATE				
Final	Original	05/23/2007							
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## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10667075	SHIKAMI ET AL.
Examiner	Art Unit

2624

SEARCHED						
Class Subclass Date Examin						
382	112, 141-152, 217-223, 257	5/23/07	AWC			
348	86-95, 125-134	5/23/07	AWC			
356	237.1-237.6	5/23/07	AWC			

Carter, Aaron W

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST Text Search (USPAT, PGPUB, DERWENT) See Search History Printout	5/23/07	AWC		
Inventor Name Search (See PALM Search History Printout)	5/23/07	AWC		
IEEE Search (See Search History Printout)	5/23/07	AWC		
Interference Search History Printout	5/23/07	AWC		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
PGPUB Text Search		5/23/07	AWC		

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